

**Notice of References Cited**

Application/Control No.

10/781,041

Applicant(s)/Patent Under  
Reexamination  
WANG ET AL.

Examiner

Betsy L. Deppe

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0172147 A1	11-2002	Matsumoto, Wataru	370/208
*	B	US-7,184,714 B1	02-2007	Kutagulla et al.	455/73
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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	X	

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